

**Search Notes**

Application/Control No.

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Hemant Patel

Applicant(s)/Patent under  
Reexamination

CHANG, HISAO M.

Art Unit

2645

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	12/22/2005	HSP
Text search only, see attached history	12/22/2005	HSP